

Lecture A.8

Linear-Size IOP for Circuits

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Foundations and Frontiers of Probabilistic Proofs
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Linear-Size IOPs for Arithmetic Computations

We have seen how to trivially adapt the basic PCP for $\text{NTIME}(T)$ into an IOP with proof length $T^{1+o(\epsilon)}$ and query complexity $(\log T)^{o(k/\epsilon)}$.

Today we see how to achieve **linear proof length for computations over large fields**.

Recall the following NP-complete language:

def: $\text{RICS}(\mathbb{F}) = \left\{ (u, \underbrace{A, B, C}_{m \times n \text{ matrices}}) \mid \exists z \in \mathbb{F}^n \text{ s.t. } Az + Bz = Cz \text{ \& } z = (u, w) \text{ for some } w \right\}$.

$$\begin{bmatrix} -a_1- \\ -a_2- \\ \vdots \\ -a_m- \end{bmatrix} \begin{bmatrix} | \\ z \\ | \end{bmatrix} + \begin{bmatrix} -b_1- \\ -b_2- \\ \vdots \\ -b_m- \end{bmatrix} \begin{bmatrix} | \\ z \\ | \end{bmatrix} = \begin{bmatrix} -c_1- \\ -c_2- \\ \vdots \\ -c_m- \end{bmatrix} \begin{bmatrix} | \\ z \\ | \end{bmatrix} \text{ i.e. } \left\{ \langle a_i, z \rangle + \langle b_i, z \rangle = \langle c_i, z \rangle \right\}_{i \in [m]}$$

theorem: For "large smooth" \mathbb{F} ,

$$\text{RICS}(\mathbb{F}) \in \text{IOP} \left[\epsilon_c = 0, \epsilon_s = 0.5, k = O(\log m), \Sigma = \mathbb{F}, \ell = O(m), q = O(\log m), r = O(\log m) \right]$$

This achieves linear-size IOPs for arithmetic computations!

Note: we cannot conclude that all of NP has linear-size proofs because reductions introduce overheads.

Today we assume for simplicity that $m=n$ (# equations = # variables).

Prior Choices of Encoding

Our recipe to construct PCPs so far has been to set $\Pi = (\Pi_a, \Pi_{\text{sat}})$ where

① Π_a is (allegedly) the encoding of a candidate assignment $[\text{belongs to } S := \{ \text{Enc}(z) \}_z]$

② if Π_a is close to $\text{Enc}(a)$ for some a , Π_{sat} facilitates checking that a is satisfying

① What encodings did we use for an assignment $a: [n] \rightarrow \mathbb{F}$?

Ⓐ for exp-size PCPs we used linear extensions (aka Hadamard code)

$$\text{Enc}(a): \mathbb{F}^n \rightarrow \mathbb{F} \quad \text{where } \text{Enc}(a) := \langle a, c \rangle_{c \in \mathbb{F}^n}$$

exponential
 $|\text{Enc}| = |\mathbb{F}|^n$

Ⓑ for poly-size PCPs we used multivariate low-degree extensions (aka Reed-Muller code)

$$\text{Enc}(a): \mathbb{F}^{\log n} \rightarrow \mathbb{F} \quad \text{where } \text{Enc}(a) := \text{"} \overset{\text{multilinear}}{(\mathbb{F}, \{0,1\}, \log n)} \text{-extension of } a \text{"}$$

almost polynomial
 $|\text{Enc}| = n^{\log |\mathbb{F}|} = n^{O(\log \log n)}$

$$\text{Enc}(a): \mathbb{F}^{\frac{\log n}{\log |\mathbb{H}|}} \rightarrow \mathbb{F} \quad \text{where } \text{Enc}(a) := \text{"} (\mathbb{F}, \mathbb{H}, \frac{\log n}{\log |\mathbb{H}|}) \text{-extension of } a \text{"}$$

polynomial
 $|\text{Enc}| = n^{\frac{\log |\mathbb{F}|}{\log |\mathbb{H}|}} = n^{1+o(\epsilon)}$

Crucially, for Ⓐ we have linearity test and for Ⓑ we have (multivariate) low-degree test.

② How to test satisfiability? For Ⓐ, random combination & tensor test. For Ⓑ, use somcheck for everything.

A New Choice of Encoding

We seek an encoding with $\left\{ \begin{array}{l} \bullet \text{ constant rate: } |\text{Enc}(a)| = O(|a|) \\ \bullet \text{ constant relative distance: } a \neq a' \rightarrow \Delta(\text{Enc}(a), \text{Enc}(a')) \geq \Omega(1) \end{array} \right.$

that lets us execute our recipe of $\Pi = (\Pi_a, \Pi_{\text{sat}})$, which in turn means that we need

- a proximity test: " Π_a close to $\{\text{Enc}(z)\}_z$ " in few queries
- an approach for testing satisfiability (eg. a replacement for somecheck protocol)

Satisfying the rate & distance alone is *easy* (pick any good code over \mathbb{F}).

Additionally satisfying the other requirements is *hard*.

continue to place our hopes in polynomials!

The new encoding that we use is: **univariate low-degree extensions**

$\text{Enc}(a): \mathbb{F} \rightarrow \mathbb{F}$ where $\text{Enc}(a) :=$ "univariate extension of $a: H \rightarrow \mathbb{F}$ " = "evaluation of $\sum_{i \in H} a(i) L_{i,H}(x)$ on \mathbb{F} "

Actually we will evaluate on $L = \#(H)$ rather than \mathbb{F} for more flexibility.

This encoding is also known as the Reed-Solomon code:

$$\text{RS}[\mathbb{F}, L, d] = \{ f: L \rightarrow \mathbb{F} \text{ s.t. } \deg(\hat{f}) \leq d \}$$

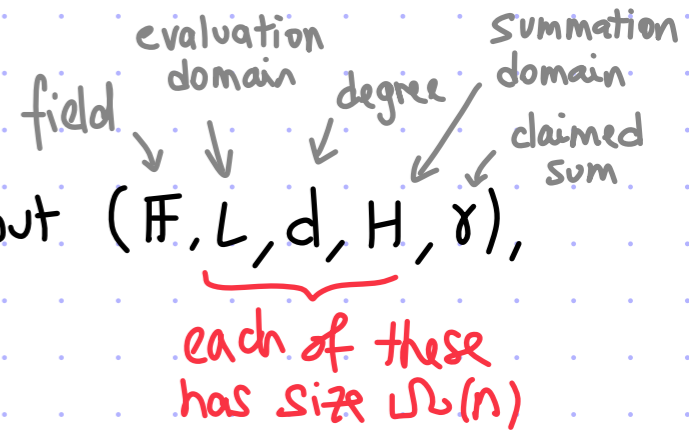
relative distance is $1 - \frac{d}{|L|} = \Omega(1)$ if $|L| = \Omega(d)$

Today:

we temporarily assume that we have a proximity test for univariate extensions, and show how to use this code to construct linear-size IDPs

Univariate Sumcheck [1/3]

The verifier has oracle access to $f: L \rightarrow \mathbb{F}$ s.t. $\deg(\hat{f}) \leq d$ and input $(\mathbb{F}, L, d, H, \gamma)$, and wants to check the claim " $\sum_{a \in H} \hat{f}(a) = \gamma$ ".



Attempt 1: query f at every $a \in H$ and add up the answers

What if $H \cap L = \emptyset$?

Deriving $f(a)$ for a single $a \in H$ requires $d+1 = \Omega(n)$ queries for interpolation.

Even if $H \subseteq L$, $|H| = \Omega(n)$ queries is too many.

[And even if H were small, in the noisy case we would use self-correction, which we don't have.]

Attempt 2: run sumcheck protocol for " $\sum_{a \in H} \hat{f}(a) = \gamma$ " with $n=1$ (e.g. as \mathbb{IP})

The first (and only) message is the $d+1 = \Omega(n)$ coefficients of \hat{f} :

$(c_0, c_1, \dots, c_d) \rightarrow V^f$: set $\tilde{f}(x) := \sum_{i=0}^d c_i x^i$ and check: $\sum_{a \in H} \tilde{f}(a) = \gamma$ & $\tilde{f}(s) = f(s)$ for random $s \in L$

This is tantamount to reading 1 (huge) symbol from the alphabet $\Sigma = \mathbb{F}^{d+1}$.

We need new ideas!

Univariate Sumcheck [2/3]

The verifier has oracle access to $f: L \rightarrow \mathbb{F}$ s.t. $\deg(\hat{f}) \leq d$ and input $(\mathbb{F}, L, d, H, \gamma)$, and wants to check the claim " $\sum_{a \in H} \hat{f}(a) = \gamma$ ".



Step 1: reduce the problem to the case $d < |H|$

Let $v_H(x) := \prod_{a \in H} (x - a)$ be the vanishing polynomial of the set H .

Divide $\hat{f}(x)$ by $v_H(x)$: $\hat{f}(x) = \hat{h}(x)v_H(x) + \hat{g}(x)$ with $\deg(\hat{g}) < |H|$ & $\deg(\hat{h}) = \deg(\hat{f}) - |H|$.

Observe that $\sum_{a \in H} \hat{f}(a) = \sum_{a \in H} \hat{g}(a)$.

Step 2: assume that H is nice and use algebra. ← similar to how multivariate sumcheck works for product sets in \mathbb{F}^n rather than all sets

lemma: if H is a subgroup of \mathbb{F}^* then $\sum_{a \in H} \hat{g}(a) = |H| \hat{g}(0)$

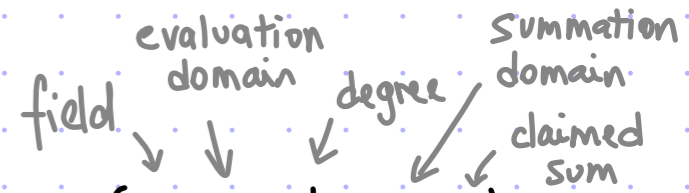
proof: First consider a monomial: $\sum_{a \in H} a^i = \sum_{j=0}^{|H|-1} (w^j)^i = \sum_{j=0}^{|H|-1} (w^i)^j = \begin{cases} 0 & \text{if } i \not\equiv 0 \pmod{|H|} \\ |H| & \text{if } i \equiv 0 \pmod{|H|} \end{cases}$.

Hence all monomials $\{x^i\}_{0 < i < |H|}$ in $\hat{g}(x)$ sum to zero, and are left with $|H|$ times $\hat{g}(0)$. ▀

Hence $\sum_{a \in H} \hat{g}(a) = \gamma$ iff $|H| \hat{g}(0) = \gamma$. [Here we saw the case of multiplicative subgroups. A similar statement holds for additive subgroups.]

Univariate Sumcheck [3/3]

The verifier has oracle access to $f: L \rightarrow \mathbb{F}$ s.t. $\deg(\hat{f}) \leq d$ and input $(\mathbb{F}, L, d, H, \gamma)$, and wants to check the claim " $\sum_{a \in H} \hat{f}(a) = \gamma$ ".



$$P((\mathbb{F}, L, d, H, \gamma), f)$$

Compute $\hat{h}(x)$ with $\deg(\hat{h}) = \deg(\hat{f}) - |H|$ and $\hat{p}(x)$ with $\deg(\hat{p}) < |H| - 1$ s.t.

$$\hat{f}(x) = \hat{h}(x) v_H(x) + (x \hat{p}(x) + \gamma/|H|)$$

Output $h := \hat{h}|_L$ and $p := \hat{p}|_L$.

$$\begin{aligned} h: L &\rightarrow \mathbb{F} \\ p: L &\rightarrow \mathbb{F} \end{aligned}$$



$$V^{f: L \rightarrow \mathbb{F}}((\mathbb{F}, L, d, H, \gamma))$$

- test that h is δ -close to degree $d - |H|$ and that p is δ -close to degree $|H| - 1$
- sample $s \in L$ and check that $f(s) = h(s) \cdot v_H(s) + (s p(s) + \gamma/|H|)$

Analysis: If $\sum_{a \in H} \hat{f}(a) = \gamma$ then verifier accepts w.p. 1. If $\sum_{a \in H} \hat{f}(a) \neq \gamma$ then distinguish between:

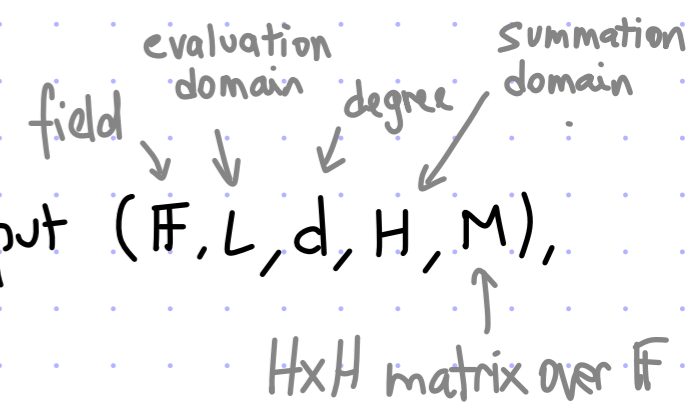
- ① \tilde{h} or \tilde{p} is δ -far from (respective) low-degree sets \rightarrow low-degree test accepts w.p. $\leq \epsilon_{\text{LDT}}(\delta)$
- ② \tilde{h} and \tilde{p} both δ -close to (unique) \hat{h} and \hat{p}

$\rightarrow \hat{f}(x) \neq \hat{h}(x) v_H(x) + (x \hat{p}(x) + \gamma/|H|)$ so identity test accept w.p. $\leq \frac{d}{|H|} + 2\delta$.

[or else \hat{f} would sum to γ]

Checking Linear Equations

The verifier has oracle access to $f, g: L \rightarrow \mathbb{F}$ of degree $\leq d$ and input (\mathbb{F}, L, d, H, M) , and wants to check the claim $\hat{g}|_H \equiv M \cdot \hat{f}|_H$.



Idea: reduce to a univariate sumcheck claim

$$\left\{ \hat{g}(a) = \sum_{b \in H} M[a,b] \cdot \hat{f}(b) \right\}_{a \in H} \text{ iff } \sum_{a \in H} \left(\hat{g}(a) - \sum_{b \in H} M[a,b] \hat{f}(b) \right) x^{\text{int}(a)} \equiv 0$$

bijection from H to $\{0, 1, \dots, |H|-1\}$

For any $r \in L$, the evaluation at r can be written as:

$$\sum_{a \in H} r^{\text{int}(a)} \hat{g}(a) - \left(\sum_{b \in H} M[b,a] r^{\text{int}(b)} \right) \hat{f}(a), \text{ equivalently } \sum_{a \in H} \underbrace{\hat{f}(a) \hat{g}(a) - \hat{r}_M(a) \hat{f}(a)}_{\text{poly of deg} \leq d + |H| - 1}$$

$P((\mathbb{F}, L, d, H, M), f, g)$

$\forall f, g: L \rightarrow \mathbb{F} ((\mathbb{F}, L, d, H, M))$

$\leftarrow r \in \mathbb{F}$

univariate sumcheck for $\sum_{a \in H} \hat{f}(a) \hat{g}(a) - \hat{r}_M(a) \hat{f}(a) = 0$

$s \in L$

- query f, g at s
- eval \hat{f}, \hat{r}_M at s

} can be done in $O(|H| + \|M\|)$ ops

The soundness error is

$$\frac{|H|-1}{|\mathbb{F}|} + \epsilon_{sc}$$

IOP for R1CS: Construction

View H in 2 parts:

H_{in}	H_{aux}
u	w

$$P((u, A, B, C), w)$$

Set $z := (u, w) \in \mathbb{F}^n$.

Shift w as follows:

$$\forall a \in H_{aux} \quad w'(a) = \frac{w(a) - \hat{u}(a)}{V_{H_{in}}(a)}$$

Compute $f_w := \hat{w}'|_L$.

For each $M \in \{A, B, C\}$:

$$\text{compute } f_M := \hat{M}z|_L$$

Compute

$$\hat{h}(x) := \frac{\hat{A}z(x)\hat{B}z(x) - \hat{C}z(x)}{V_H(x)}$$

For each $M \in \{A, B, C\}$:

compute $\hat{g}_M(x)$ and $\hat{h}_M(x)$ s.t.

$$\hat{f}(x)\hat{M}z(x) - \hat{r}_M(x)z(x) = \hat{h}_M(x)V_H(x) + x\hat{p}_M(x)$$

$$f_w, f_A, f_B, f_C, h: L \rightarrow \mathbb{F}$$

$f: L \rightarrow \mathbb{F}$ is defined as
 $f(a) := f_w(a)V_{H_{in}}(a) + \hat{u}(a)$

$$\leftarrow r \in \mathbb{F}$$

For each $M \in \{A, B, C\}$:

univariate sumcheck for
 $\sum_{a \in H} \hat{r}(a)\hat{f}_M(a) - \hat{r}_M(a)\hat{f}(a) = 0$

$$P_M, h_M: L \rightarrow \mathbb{F}$$

$$V((u, A, B, C))$$

- Sample $s \in L$ at random.

- $f_A(s)f_B(s) - f_C(s) = h(s)V_H(s)$

- For each $M \in \{A, B, C\}$:

$$\hat{f}(s)\hat{f}_M(s) - \hat{r}_M(s)\hat{f}(s) = h_M(s) \cdot V_H(s) + s \cdot \hat{p}_M(s)$$

- Test that:

- f_A, f_B, f_C are δ -close to degree $|H|-1$

- h is δ -close to degree $|H|-2$

- h_A, h_B, h_C are δ -close to degree $|H|-2$

- g_A, g_B, g_C are δ -close to degree $|H|-2$

[actually the three sumchecks can be merged into one via random coeffs]

IOP for R1CS: Soundness

Suppose that $(u, A, B, C) \notin \text{R1CS}$.

If any of the sent functions is δ -far then we are done. So **suppose all are δ -close**.

Let $\hat{f}_w, \hat{f}_A, \hat{f}_B, \hat{f}_C, \hat{h}, \hat{p}_A, \hat{h}_A, \hat{p}_B, \hat{h}_B, \hat{p}_C, \hat{h}_C$ be the (unique) closest low-degree polynomials.

One of the following must be true.

① the Hadamard product condition is violated: $\hat{f}_A|_H \circ \hat{f}_B|_H \neq \hat{f}_C|_H$

② one of the linear conditions is violated: $\exists M \in \{A, B, C\}$ s.t. $\hat{f}_M|_H \neq M \cdot \hat{f}|_H$

In case ①: $\hat{f}_A(x) \cdot \hat{f}_B(x) - \hat{f}_C(x) \neq \hat{h}(x) V_H(x)$ so the verifier accepts w.p. $\leq \frac{2|H|-2}{|H|} + 4\delta$

degree in polynomial equation $\rightarrow |H|$

\leftarrow 1 query each to 4 functions that are δ -far from LD

In case ②: except w.p. $\frac{|H|-1}{|F|}$ over $r \in \mathbb{F}$, $\hat{f}(x) \hat{f}_M(x) - \hat{f}_M(x) \hat{f}(x) \neq \hat{h}_M(x) V_H(x) + x \hat{p}_M(x)$

in which case the verifier accepts w.p. $\leq \frac{2|H|-2}{|H|} + 4\delta$.

[Note that input consistency is accounted for:
 $\hat{f}(x) := \hat{f}_w(x) V_{H_{in}}(x) + \hat{u}(x)$]

$P(u, A, B, C), w$

Set $z := (u, w) \in \mathbb{F}^n$.

Shift w as follows:
 $\forall a \in H_{in} \quad w(a) = \frac{w(a) - \hat{u}(a)}{V_{H_{in}}(a)}$

Compute $f_w := \hat{w}|_L$.

For each $M \in \{A, B, C\}$:
 compute $f_M := \hat{M}_z|_L$

Compute $\hat{h}(x) := \frac{\hat{A}_z(x) \hat{B}_z(x) - \hat{C}_z(x)}{V_H(x)}$

For each $M \in \{A, B, C\}$:
 compute $\hat{g}_M(x)$ and $\hat{h}_M(x)$ s.t.
 $\hat{f}(x) \hat{M}_z(x) - \hat{f}_M(x) \hat{f}(x) = \hat{h}_M(x) V_H(x) + x \hat{p}_M(x)$

$f_w, f_A, f_B, f_C, h: L \rightarrow \mathbb{F}$

$f: L \rightarrow \mathbb{F}$ is defined as
 $f(a) := f_w(a) V_{H_{in}}(a) + \hat{u}(a)$

$r \in \mathbb{F}$

For each $M \in \{A, B, C\}$:
 univariate sumcheck for
 $\sum_{a \in H} \hat{f}(a) \hat{f}_M(a) - \hat{f}_M(a) \hat{f}(a) = 0$
 $p_M, h_M: L \rightarrow \mathbb{F}$

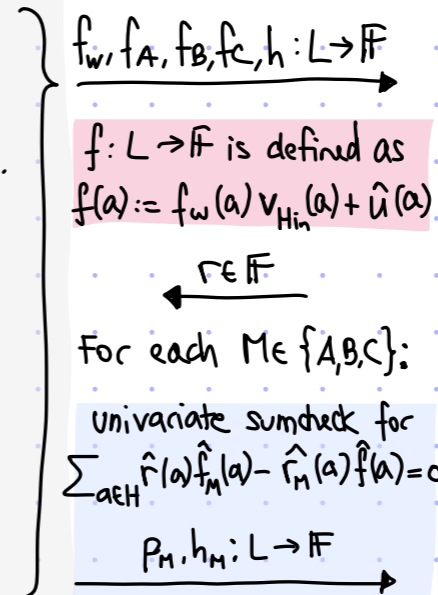
$V(u, A, B, C)$

- Sample $s \in L$ at random.
- $f_A(s) f_B(s) - f_C(s) = h(s) V_H(s)$
- For each $M \in \{A, B, C\}$:
 $\hat{f}(s) \hat{f}_M(s) - \hat{f}_M(s) \hat{f}(s) = h_M(s) \cdot V_H(s) + s \cdot p_M(s)$
- Test that:
 - f_A, f_B, f_C are δ -close to degree $|H|-1$
 - h is δ -close to degree $|H|-2$
 - h_A, h_B, h_C are δ -close to degree $|H|-2$
 - g_A, g_B, g_C are δ -close to degree $|H|-2$

IOP for R1CS: Efficiency

- proof complexity (in field elts):
 $O(|L| + \ell_{\text{LDT}}) = O(n + \ell_{\text{LDT}}) = O(n)$
- query complexity:
 $O(1) + q_{\text{LDT}} = O(\log n)$
- round complexity:
 $O(1) + k_{\text{LDT}} = O(\log n)$
- randomness complexity (in field elts):
 $O(1) + r_{\text{LDT}} = O(\log n)$
- prover time: $[*]$
 $O(|L| \log |L|) + pt_{\text{LDT}} = O(n \log n)$

$P((u, A, B, C), w)$
 Set $z := (u, w) \in \mathbb{F}^n$.
 Shift w as follows:
 $\forall a \in H_{\text{aux}} \quad w(a) = \frac{w(a) - \hat{u}(a)}{V_{H_{\text{in}}}(a)}$
 Compute $f_w := \hat{w}|_L$.
 For each $M \in \{A, B, C\}$:
 compute $f_M := \hat{M}z|_L$.
 Compute
 $\hat{h}(x) := \frac{\hat{A}z(x)\hat{B}z(x) - \hat{C}z(x)}{V_H(x)}$
 For each $M \in \{A, B, C\}$:
 compute $\hat{g}_M(x)$ and $\hat{h}_M(x)$ s.t.
 $\hat{f}(x)\hat{M}z(x) - \hat{f}_M(x)\hat{z}(x) = \hat{h}_M(x)V_H(x) - x\hat{p}_M(x)$



$V((u, A, B, C))$

- Sample $s \in L$ at random.
- $f_A(s)f_B(s) - f_C(s) = h(s)V_H(s)$
- For each $M \in \{A, B, C\}$:
 $\hat{f}(s)\hat{f}_M(s) - \hat{f}_M(s)\hat{f}(s) = h_M(s) \cdot V_H(s) + s \cdot p_M(s)$
- Test that:
 - f_A, f_B, f_C are δ -close to degree $|H|-1$
 - h is δ -close to degree $|H|-2$
 - h_A, h_B, h_C are δ -close to degree $|H|-2$
 - g_A, g_B, g_C are δ -close to degree $|H|-2$

- verifier time: $[*]$
 $O(|L|) + vt_{\text{LDT}} = O(n)$

We have constructed IOPs of linear size for R1CS:

$[*]$: both pt & vt also include the term $O(|A| + |B| + |C|)$ to multiply vectors by A, B, C

theorem: For every field \mathbb{F} of size $\Omega(n)$ that is smooth \leftarrow for LDT

$$R1CS(\mathbb{F}) \subseteq \text{IOP} \left[\begin{array}{l} \epsilon_c = 0, \epsilon_s = 0.5, \Sigma = \mathbb{F}, pt = O(n \log n), vt = O(n) \\ k = O(\log n), r = O(\log n), \ell = O(n), q = O(\log n) \end{array} \right]$$

We are left to construct a univariate LDT with logarithmically-many queries.